Integer and fractional quantum anomalous Hall effects in pentalayer graphene

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We critically analyze the recently reported observation of integer (IQAHE) and fractional (FQAHE) quantum anomalous Hall effects at zero applied magnetic field in pentalayer graphene. Our quantitative activation and variable range hopping transport analysis of the experimental data reveals that the observed IQAHE and FQAHE at different fillings all have similar excitation gaps of the order of 5-10 K. In addition, we also find that the observed FQAHE manifests a large hidden background contact series resistance >10 k Ω of unknown origin whereas this contact resistance is much smaller \sim 500 Ω in the observed IQAHE. Both of these findings are surprising as well as inconsistent with the well-established phenomenology of the corresponding high-field integer and fractional quantum Hall effects in two-dimensional semiconductor systems.

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The recent transport observation of zero-field integer (IQAHE) and fractional (FQAHE) quantum anomalous Hall effects in pentalayer graphene [1], just after the report of the same discovery in twisted $MoTe_2$ [2,3], is an important breakthrough. Graphene is relatively clean, allowing the possibility of seeing novel quantum Hall effect (QHE) physics, perhaps not necessarily accessible in dirtier transition metal dichalcogenide (TMD) materials. It should be mentioned as an aside that the original high-field IQHE was first observed [4] in two-dimensional (2D) Si-SiO₂ metal-oxide semiconductor field-effect transistors (MOSFETs) with low mobilities $(\sim 10^3 \text{ cm}^2/\text{V s})$ whereas the first observation [5] of a fractional quantum Hall effect (FOHE) was in much cleaner 2D GaAs-AlGaAs heterostructures with much higher mobilities $(\sim 10^5 \text{ cm}^2/\text{V s})$. To the best of our knowledge, FQHE has yet to be decisively reported in transport experiments on Si-SiO₂ MOSFETs because of their high disorder. It is therefore remarkable that the zero-field version of quantum Hall effects manifested simultaneously as IQAHE and FQAHE in both TMD and graphene. Indeed, Ref. [1] reports the observation of "plateaus" of quantized Hall resistance $R_{xy} = h/ve^2$ at the integer band filling v = 1 as well as several fractional band fillings v = 2/3, 3/5, 2/5, 4/9, 3/7, and 4/7 accompanied by clear dips in the longitudinal resistance. The current work follows our earlier work on TMD [6], and focuses on a detailed analysis of the experimental IQAHE/FQAHE results presented in Ref. [1].

The qualitative differences between regular high-field QHEs and the recently observed IQAHE/FQAHE are as follows: (1) high magnetic field versus zero magnetic field; (2) magnetic-field-induced continuum Landau levels (LLs) versus lattice-induced flat bands with nontrivial topology (i.e., Chern insulators with a nontrivial Chern number); and (3) explicit breaking of the time-reversal symmetry by an external magnetic field versus the spontaneous breaking of the time-reversal symmetry in a Chern band. The interplay of continuum LLs and a lattice in the context of IQHE/FQHE has a long history going back to the early seminal papers [7-9]. Later, ideas were proposed to create FQHE in atomic optical lattices [10]. Occasionally, specific models for creating flat bands, which are necessary (but not sufficient) for IQAHE, in 2D lattices were discussed, but without any embedded topology or time-reversal symmetry breaking [11]. Finally, in 2011, several theoretical groups proposed 2D lattice models where the bands are both relatively flat and have intrinsic topology (i.e., finite Chern number), leading to the specific idea of quantum Hall effects without any applied field [12–16]. It was obvious right from the beginning (and also verified by explicit numerical simulations) that such Chern bands, when fractionally occupied, would manifest FQAHE. The possibility of Chern insulators with Chern numbers larger than one and the role of disorder in IQAHE/FQAHE in such Chern insulators were also considered in this early theoretical literature [17,18]. More recently, a specific prediction for the occurrence of fractional Chern insulators in twisted 2D moiré systems was made [19]. However, the subject remained strictly theoretical without any experimental realization for 12 years until 2023 when three groups realized Chern insulators with observations of IQAHE/FQAHE in TMD and pentalayer graphene moiré systems in transport experiments [1-3].

Given that IQAHE/FQAHE phenomena in flat-band Chern insulators were already predicted as a matter of principle a long time ago, their observations bring up three important theoretical questions: (1) Is the observed zerofield IQAHE/FQAHE in 2D lattice systems adiabatically connected to the corresponding well-established high-field IQHE/FQHE in continuum LL systems? (2) Can the observed experimental IQAHE/FQAHE phenomenology theoretically quantitatively explicable using the actual TMD and pentalayer graphene lattices? (3) Are there new fractions where FQAHE manifest with no corresponding FQHE analogs? Our current Letter illuminates on these questions by critically analyzing the reported pentalayer graphene data in depth and showing that the reported IQAHE/FQAHE in graphene has serious quantitative disagreement with the corresponding high-field IQHE/FQHE phenomenology, indicating that perhaps the observed IQAHE/FQAHE may *not* necessarily be adiabatically connected to the high-field quantum Hall physics. This is, at this early stage of the subject, at best a tentative conclusion since experimental results are likely to improve rapidly as sample quality improves and experimental problems are resolved, but the subject is of sufficient importance for the community to think about this issue.

We emphasize in this context that no theoretical work [20–26] to date provides even a semiquantitative explanation for the experimental observations of the pentalayer graphene IQAHE/FQAHE. For example, theories either find FQAHE both [20–22,25] or neither [27] for v = 1/3 and 2/3 in graphene whereas Ref. [1] reports the v = 2/3, but not the v = 1/3 FQAHE. At this stage we do not know whether or not the reported existence (nonexistence) of v = 2/3(1/3) FQAHE is an unimportant detail. On the other hand, Ref. [1] reports FQAHE precisely at the primary Jain fractional fillings arising from the composite fermion theory (except for 1/3 filling) as developed for the LL FQHE.

In the rest of this Letter we present our detailed analysis of the temperature-dependent longitudinal resistance R_{xx} using the experimental data in Ref. [1] to obtain the IQAHE/FQAHE excitation gaps at various fillings. We also find that, similar to the situation in TMD IQAHE/FQAHE [6], pentalayer graphene data also imply a hidden (and often large) series resistance R_0 in the longitudinal resistance, whose origin remains a mystery (since four-probe measurements should not usually manifest any contact resistance). We provide the excitation gaps and the contact resistance for all the fillings where Ref. [1] reports the observation of an apparent quantization of R_{xy} .

We start from an overall examination of the degree of quantization for both the integer and fractional filling states. Figure 1 plots the Hall (G_{xy}) and longitudinal (G_{xx}) conductances as a function of filling factor. The conductances are calculated from the resistance data [shown in Fig. 3(c) of Ref. [1]] measured in a constant current setup by $G_{xx/xy} =$ $R_{xx/xy}/(R_{xx}^2 + R_{xy}^2)$. While both the integer and fractional plateaus are accompanied by clear dips in G_{xx} , the residual resistance (and thereby the conductance) is significant (~ 10 $k\Omega$) in the fractional cases, several orders of magnitude higher compared to the integer case, which can reach as low as $\sim 10 \Omega$ [1]. In fact, the surprise here is why and how the FQAHE shows up at six different fractional fillings in spite of a huge background resistance-this certainly does not happen in regular FQHE. The existence of a large ($\sim 10 \text{ k}\Omega$) residual resistance concomitant with the manifestation of clear FQAHE sharply distinguishes the lattice FQAHE from LL FQHE, and this calls for a deeper understanding of the relative roles of edge versus bulk transport in FQAHE to figure out what is this mysterious R_0 .

To have a quantitative understanding, we focus on the temperature dependence of the longitudinal resistance R_{xx} . In ideal clean systems, because of the ballistic transport along the chiral edge channels, the longitudinal resistance is expected to vanish in the limit of zero temperature. As temperature rises, thermally activated carriers in the bulk contribute to finite resistance, which follows the thermal activation behavior with $R_{xx} \propto e^{-\Delta/2k_BT}$, where Δ is the bulk charge excitation gap. Additional mechanisms contributing to R_{xx} are Mott [28] and



FIG. 1. (a) Hall and (b) longitudinal conductances of the pentalayer graphene/hBN as a function of filling factor ν . G_{xy} and G_{xx} are obtained by inverting the resistances data from the source data of Fig. 3(c) in Ref. [1]. The vertical dashed lines represent the fillings manifesting the IQAHE/FQAHE, and the horizontal bars mark the expected quantized Hall conductance values. Note that the measured quantities are the resistances, and our fitting is done on $R_{xx}(T)$.

Efros-Shklovskii (ES) [29] variable range hopping (VRH) facilitated by phonons, and the relative importance of the three transport mechanisms in IQAHE/FQAHE is unknown.

Here, we fit the experimental temperature dependence of R_{xx} to all three transport mechanisms in an unbiased manner. In addition, we include an extra term, the contact resistance R_0 , which was found to be essential in the TMD IQAHE/FQAHE [6]. We remark that the exact origin of R_0 is unclear at the moment; the fact that R_0 exists is apparent in the experimental data since the measured R_{xx} , instead of becoming vanishingly small at the FQAHE plateau, saturates to a large value. Specifically, we adopt the fitting formula R(T) = $R_0 + Ae^{-\Delta/2k_BT}$ for the thermal activation mechanism, and $R(T) = R_0 + Ae^{-(T_0/T)^{1/n}}$ for Mott (n = 3) and ES (n = 2)VRH mechanisms, where A and T_0 are model-dependent constants treated as free-fitting parameters. Below we present our fitting results for filling factors $\nu = 1$, 2/3, 3/5, 2/5, and 4/9. We provide our fitted results for $\nu = 3/7$ and 4/7 also (see Table I), but do not show the actual fittings for brevity.

At the integer filling v = 1, R_{xx} increases with increasing temperature (or decreasing T^{-1}) and saturates at a temper-

TABLE I. Summary of the fitting parameters for thermal activation fitting of the longitudinal resistance R_{xx} . The parameters are extracted from the optimal fitting result at each filling factor. Δ and R_0 are in units of degrees Kelvin (K) and k Ω , respectively.

ν	1	2/3	3/5	2/5	4/9	3/7	4/7
ΔR_0	9.5	5.0	5.7	5.3	5.5	4.9	5.0
	0.53	12.62	13.25	16.49	12.30	12.12	10.29



FIG. 2. Thermal activation fitting of the longitudinal resistance R_{xx} at filling factor v = 1. (a) and (b) are fittings without contact resistance and (c) and (d) are fittings with a contact resistance R_0 as a fitting parameter. The red lines are experiment data and blue lines are the fitting curves. Data in the shaded region are excluded from fitting.

ature of $T_s \approx 3$ K as shown in Fig. 2. Below T_s , thermal activation fitting without R_0 fails to match the overall temperature dependence, as shown in Figs. 2(a) and 2(b), with only piecewise matchings yielding drastically different gap values depending crucially on the fitting range. With a finite R_0 , the fitting appears to have a significantly better agreement with the measured data as demonstrated in Fig. 2(d). The temperature range close to T_s manifests a different behavior [shown in Fig. 2(c)] likely due to the saturation effect. The residual resistance is generally small but can vary from ~ 100 to $\sim 10 \Omega$ [1] depending on detailed parameters such as the vertical displacement field. The extracted value for the gap is $\Delta \approx 9.5$ K. We emphasize that our extracted (rather small) IQAHE gap (\sim 9.5 K) is consistent with the experimental finding that the IQAHE disappears for T > 2 K which argues against a large gap. Similarly, the measured R_{xx} at the lowest temperatures is $\sim 10-100 \ \Omega$ at the IQAHE plateau in Ref. [1] consistent with our fitted R_0 .

We further apply the Mott and ES VRH mechanisms to fit the temperature dependence of R_{xx} at v = 1. Figure 3 presents the optimal fitting results without [Figs. 3(a) and 3(b)] and with [Figs. 3(c) and 3(d)] a contact resistance, which clearly demonstrates the necessity to include R_0 . The fact that the VRH and thermal activation mechanisms can both fit the experimental data suggests the mechanism of finite temperature R_{xx} is uncertain.

For FQAHE, the longitudinal resistances R_{xx} have similar trends but differ quantitatively compared to the integer case. We begin with the filling factor v = 2/3, which is the most robust fractional state. As shown in Fig. 4, R_{xx} first increases and then decreases as the temperature *T* increases. Similar to the integer case, inclusion of R_0 is necessary to fit the temperature dependence. We find only minor variations in the thermal activation fitting parameters when adjusting the





FIG. 3. Variable range hopping fittings of the longitudinal resistance R_{xx} at filling factor $\nu = 1$. The left panels are Mott VRH fittings (a) without and (c) with a contact resistance R_0 . The right panels are ES VRH fittings (b) without and (d) with a contact resistance R_0 . The figure conventions are the same as in Fig. 2.

temperature window [as shown in Figs. 4(c) and 4(d)] [30]. The optimal gap value from our fitting is $\Delta = 5.0$ K, approximately half of that for the integer case. The contact resistance $R_0 = 12.62 \ k\Omega$, on the other hand, is two orders of magnitude larger than the integer case. Our extracted fractional gap ~ 5 K and $R_0 \sim 10 \ k\Omega$ are consistent with the experimental FQAHE disappearing below 1 K and the experimental R_{xx} manifesting a resistance of $\sim 10 \ k\Omega$ around the fractional plateau at the lowest temperatures, respectively. We perform a similar thermal activation fitting analysis for several other fractional filling factors. Figures 5–7 show the fitting results for $\nu = 3/5$, 2/5, and 4/9, respectively ($\nu = 3/7$ and 4/7 are not shown). The longitudinal resistances in these cases follow



FIG. 4. Thermal activation fitting of the longitudinal resistance R_{xx} at filling factor $\nu = 2/3$. (a) and (b) are fittings without contact resistance and (c) and (d) are fittings with a contact resistance R_0 . The figure conventions are the same as in Fig. 2.



FIG. 5. Thermal activation fitting of the longitudinal resistance R_{xx} at filling factor $\nu = 3/5$. (a) and (b) are fittings without contact resistance and (c) and (d) are fittings with a contact resistance R_0 . The figure conventions are the same as in Fig. 2.

similar trend with a saturation (or turnover) temperature $T_s \approx 1$ K. Again, for $T < T_s$, thermal activation fitting with finite R_0 works well in all cases yielding similar R_0 values $\sim 10 \ \text{k}\Omega$. Table I summarizes the fitting parameters from all the thermal activation fittings. We remark that our fitting method aligns with standard practices in the extensive FQHE literature. Although using all three transport mechanisms yields somewhat better fits, it involves too many parameters, making the fitting less meaningful.

The most interesting and important aspect of our results, summarized in Table I, is that the FQAHE gap is consistently around 5 K for all the fractional fillings, and the IQAHE gap is within a factor of 2 of the FQAHE gap. However, the experimental quantization is far better for v = 1 than for the fractional fillings, which is likely caused by the effective



FIG. 6. Thermal activation fitting of the longitudinal resistance R_{xx} at filling factor v = 2/5. (a) and (b) are fittings without contact resistance and (c) and (d) are fittings with a contact resistance R_0 as a fitting parameter. The figure conventions are the same as in Fig. 2.

 R_{xx} at filling factor $\nu = 4/9$. (a) and (b) are fittings without contact resistance and (c) and (d) are fittings with a contact resistance R_0 as a fitting parameter. The figure conventions are the same as in Fig. 2. background contact resistance R_0 being orders of magnitude larger for the fractional cases (>10 k Ω) than in the integer case (~10–100 Ω). We mention that if we blindly convert $R_0 \sim 10$ k Ω to a broadening using the actual carrier density

larger for the fractional cases (>10 k Ω) than in the integer case (~10–100 Ω). We mention that if we blindly convert $R_0 \sim 10$ k Ω to a broadening using the actual carrier density and the very light carrier effective mass (~0.05 m_e) of pentalayer graphene, we get a huge broadening ~500 K. The actual transport broadening is, however, likely to be much smaller ~10 K as reflected from the onset of the Shubnikov–de Haas (SdH) oscillations at 0.4 T applied field. This 10 K broadening is consistent with the IQAHE value of $R_0 \sim 100 \Omega$. The biggest puzzle is perhaps the almost constancy of

the gap values across all observed FOAH states. Since the observed fractions are precisely (except for the absence of the 1/3 state) the primary Jain sequence v = p/(2p+1) or (p+1)/(2p+1) with p = 1, 2, 3..., exactly as occurring in the continuum high-field 2D GaAs LL FQHE experiments [31-33], it is reasonable to assume an adiabatic continuity between the continuum LL and the flat-band lattice systems. By contrast, however, the composite fermion theory in the continuum system, which is well verified both experimentally [32,33] and theoretically [34,35], specifically predicts that the excitation gap should scale as 1/(2p+1)whereas the experimental pentalayer graphene FQAH gaps in Table I show no dependence on p (or v). For example, the composite fermion theory [36,37] as applied to the current graphene FQAHE would predict the gap at 2/3 to be three times the gap at 4/9 (and this is exactly what is observed experimentally in LL FQHE [33]) whereas our FQAHE analysis in Table I finds the gap at 4/9 to be slightly larger. It is possible that the flat-band lattice FQAHE represents a distinct type of topological order different from its continuum LL counterpart since the lattice version, in principle, has many additional topological invariants imposed by lattice translational symmetries [38,39]. It is too soon to decide whether some deep significance should be attached to the excitation gap being almost a constant for all the FQAH states (Table I) or this is simply an artifact of the system being highly

1.0

1.0

1.0

1.0

(b)

 R_{xx} (k Ω)

2.5

(d)

 4×10

 $\widehat{\underline{g}}$ 3×10¹

 $\approx^{3} 2 \times 10^{1}$

FIG. 7. Thermal activation fitting of the longitudinal resistance

 4×10^{10}

 3×10^{10}

 2×10^{10}

101

T (K) 0.6

1.5

 $1/T (K^{-1})$

T (K) 0.6

1.5

 $1/T (K^{-1})$

Raw Data

Fi

= 1.2K

2.0

Raw Data

Fit

 $R_0 = 13.39 \, k\Omega$

2.0

 $\Delta = 6.9 \text{K}$

2.5

T (K) 0.6

1.5

 $1/T \, ({\rm K}^{-1})$

T (K) 0.6

1.5

 $1/T (K^{-1})$

Raw Data

Fit

2.0

Raw Data

Fit

 $= 12.30 k\Omega$

2.0

 $\Delta = 5.5 \text{K}$

 $\Delta = 2.7 \text{K}$

1.0

1.0

1.0

1.0

(a)

 R_{xx} (k Ω)

(c)

 4×10

 3×10

 2×10^{1}

 4×10

 $\widehat{g}^{3\times 10^{1}}$

 $\stackrel{\sharp}{\approx} 2 \times 10^{1}$



FIG. 8. (a)–(d) Mott and (e)–(h) ES VRH fittings of the longitudinal resistance R_{xx} at fractional filling factors with (a), (e) for $\nu = 2/3$, (b), (f) for $\nu = 3/5$, (c), (g) for $\nu = 2/5$, and (d), (h) for $\nu = 4/9$. The figure conventions are the same as in Fig. 2.

disordered, particularly since the observed FQAHE sequence in graphene is precisely the same as the primary Jain sequence predicted for the continuum FQHE. We do, however, believe that our Table I represents an important empirical fact about FQAHE which future theories must be able to explain.

We also perform VRH fittings for the fractional cases considered above. The fitting results are shown in Fig. 8 with the Mott fittings in the top row and ES fittings in the bottom row. Both VRH models are able to fit the R_{xx} data. The extracted R_0 values are consistent with the thermal activation results in Table I. It is clear from these results that we cannot unambiguously pin down the nature of the transport mechanism and therefore should be cautious about adopting the gap value extracted from the thermal activation fitting, accepting them as tentative findings until future results in better samples with much lower values of R_0 are reported.

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